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| Notice of References Cited | Application/Control No. 09/945,553 | | Applicant(s)/Patent Under Reexamination GONZALEZ ET AL. | |
| | Examiner George Fourson | | Art Unit 2823 | Page 1 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-2001/0014522 | 08-2001 | WEIMER et al. | 438/591 |
| * | B | US-2002/0173150 | 11-2002 | Kawai et al. | 438/690 |
| * | C | US-2004/0132272 | 07-2004 | Ku et al. | 438/585 |
| * | D | US-5,672,525 | 09-1997 | Pan, Yang | 438/505 |
| * | E | US-2004/0063276 | 04-2004 | Yamamoto et al. | 438/241 |
| * | F | US-2005/0085074 | 04-2005 | Powell, Don Carl | 438/689 |
| * | G | US-2003/0045113 | 03-2003 | Enomoto et al. | 438/706 |
| * | H | US-2002/0004263 | 01-2002 | Tanabe et al. | 438/199 |
| * | I | US-2004/0051153 | 03-2004 | Yamamoto et al. | 257/412 |
| * | J | US-2004/0171241 | 09-2004 | Kitamura et al. | 438/592 |
| * | K | US-2004/0259339 | 12-2004 | Tanabe et al. | 438/585 |
| * | L | US-2004/0266154 | 12-2004 | Lim et al. | 438/592 |
| * | M | US-2005/0019992 | 01-2005 | Hong et al. | 438/149 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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NON-PATENT DOCUMENTS

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|---|---|---|
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|-----------------------------------|---------------------------------------|--|---|-------------|
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| | Examiner George Fourson | | Art Unit 2823 | Page 2 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-6,288,419 | 09-2001 | Prall et al. | 257/213 |
| * | B | US-6,417,551 | 07-2002 | Miyano, Kiyotaka | 257/412 |
| * | C | US-6,593,229 | 07-2003 | Yamamoto et al. | 438/635 |
| * | D | US-6,774,012 | 08-2004 | Narayanan, Sundar | 438/471 |
| * | E | US-7,029,999 | 04-2006 | Lim et al. | 438/585 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

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| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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